

**Notice of References Cited**

Application/Control No.

09/940,876

Applicant(s)/Patent Under  
Reexamination  
HIGASHI ET AL.

Examiner

David E Graybill

Art Unit

2827

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,220,499	04-2001	Brofman et al.	228/180.22
	B	US-6,356,686	03-2002	Kuczynski, Joseph Paul	385/39
	C	US-6,207,728	03-2001	Sekiguchi et al.	522/83
	D	US-6,084,308	07-2000	Kelkar et al.	257/777
	E	US-6,255,899	07-2001	Bertin et al.	327/564
	F	US-6,159,767	12-2000	Eichelberger, Charles William	438/107
	G	US-5,198,963	03-1993	Gupta et al.	361/715
	H	US-6,291,267	09-2001	Dore et al.	438/108
	I	US-5,963,429	10-1999	Chen, Philip H.	361/764
	J	US-5,760,478	06-1998	Bozso et al.	257/777
	K	US-5,646,828	07-1997	Degani et al.	361/715
	L	US-5,608,262	03-1997	Degani et al.	257/723
	M	US-6,294,407	09-2001	Jacobs, Scott L.	438/118

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.